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THE UNITED STATES OF AMERICA
 AUG 25 2006
 KIMBACHY et al
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Group Art Unit: 3737

Attorney
Docket: 25854

Examiner: CHAO, ELMER M

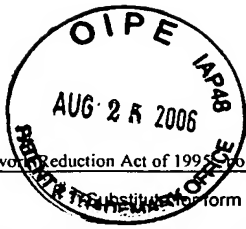
SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Enclosed is a PTO Form 1449 which lists citations which may be material to the patentability and examination of the above identified application. Also enclosed are copies of the references cited. These are submitted in compliance with the duty of disclosure defined in 37 CFR 1.56. The Examiner is requested to make these citations of official record in this application.

This Supplemental Information Disclosure Statement under 37 CFR 1.56 is not to be construed as a representation that a search has been made, that additional matter which is material to the examination of this application does not exist, or that any or more of these citations constitutes prior art.

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Dated: August 9, 2006



PTO/SB/08a (08-03)

Approved for use through 07/31/2006. OMB 0651-0031

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SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)				Complete if Known		
Sheet		1		of 2		
U.S. PATENT DOCUMENTS				Application Number		10/616,301
				Filing Date		July 10, 2003
				First Named Inventor		Yoav KIMCHY et al
				Art Unit		3737
				Examiner Name		CHAO, ELMER M
				Attorney Docket Number		25854
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document		Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	1	US-6,567,687	05-20-2003	Front et al.		
	2	US-2002/0087101	04-4-2002	Barrick et al.		
	3	US-5,694,933	09-9-1997	Madden et al.		
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Examiner Initials*	Cite No. ¹	Foreign Patent Documents Country Code ³ : Number ⁴ : Kind Code ⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T 6
	32	PCT WO 02/058531	01-1-2002	Kimchy et al.		
	33	PCT WO 02/16965	02-28-2002	Kimchy et al.		
Examiner Signature				Date Considered		

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of copy of this form with next communication to applicant. ¹ Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3).

